

ATLAS

Level-1 Calorimeter Trigger Meeting

Stockholm 2002



PPrASIC and MCM status and test plans

First ASIC Tests

- Power
- Temperature

MCM

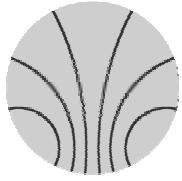
- Mounted MCM
- MCM-Test Parts
- Mounted MCM-Test Setup
- MCM status and test plans

ASIC

- ASIC-Test Parts
- Mounted ASIC-Test Setup
- ASIC-Test Installed
- ASIC test plans

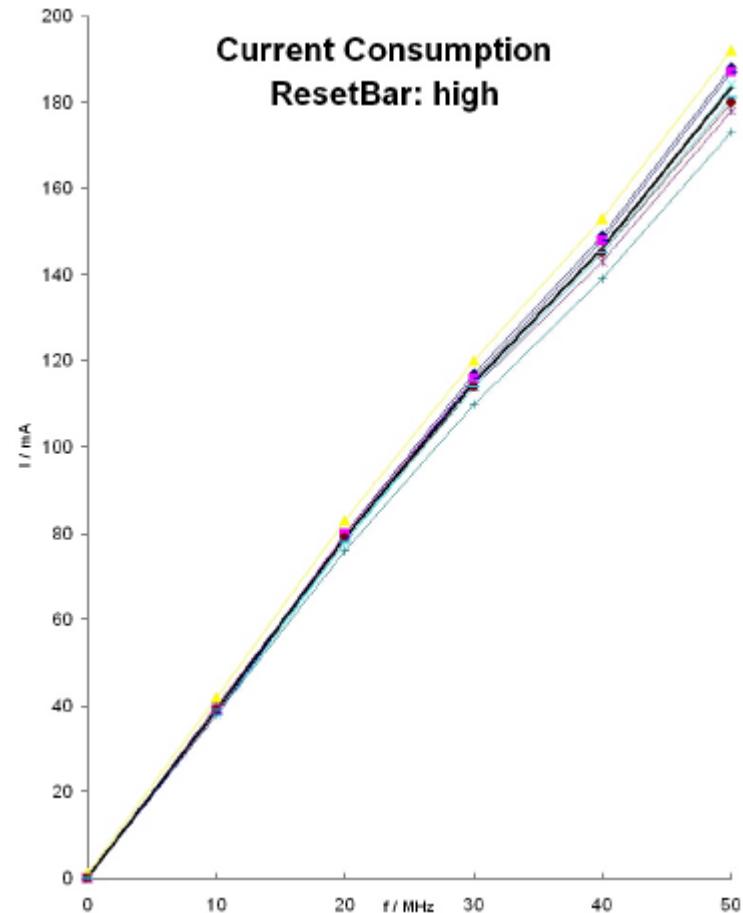
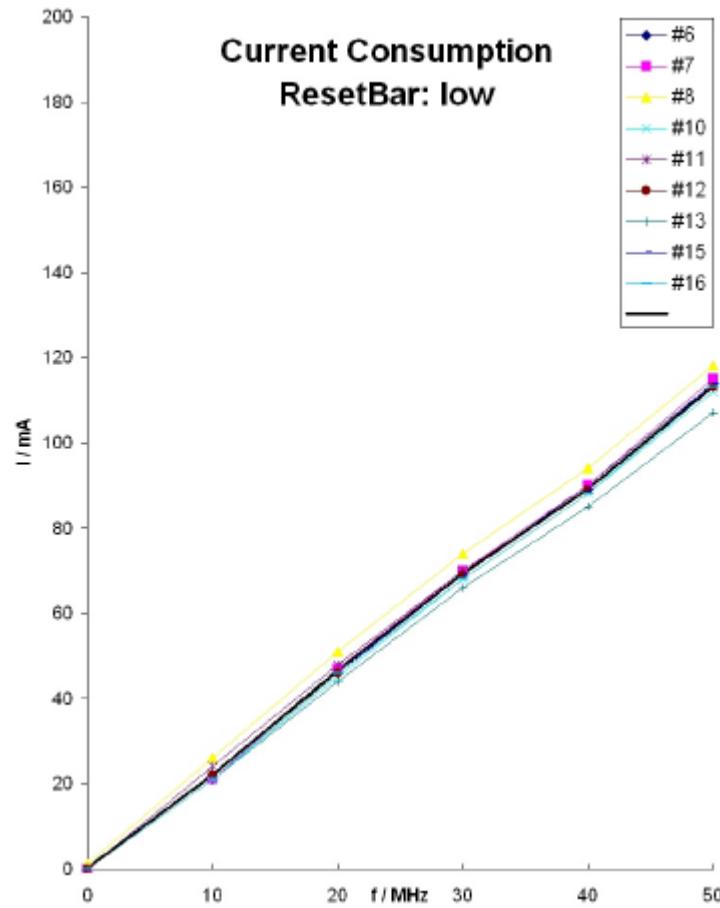
Outlook

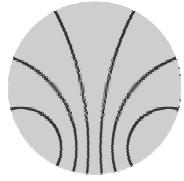
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



First ASIC Tests

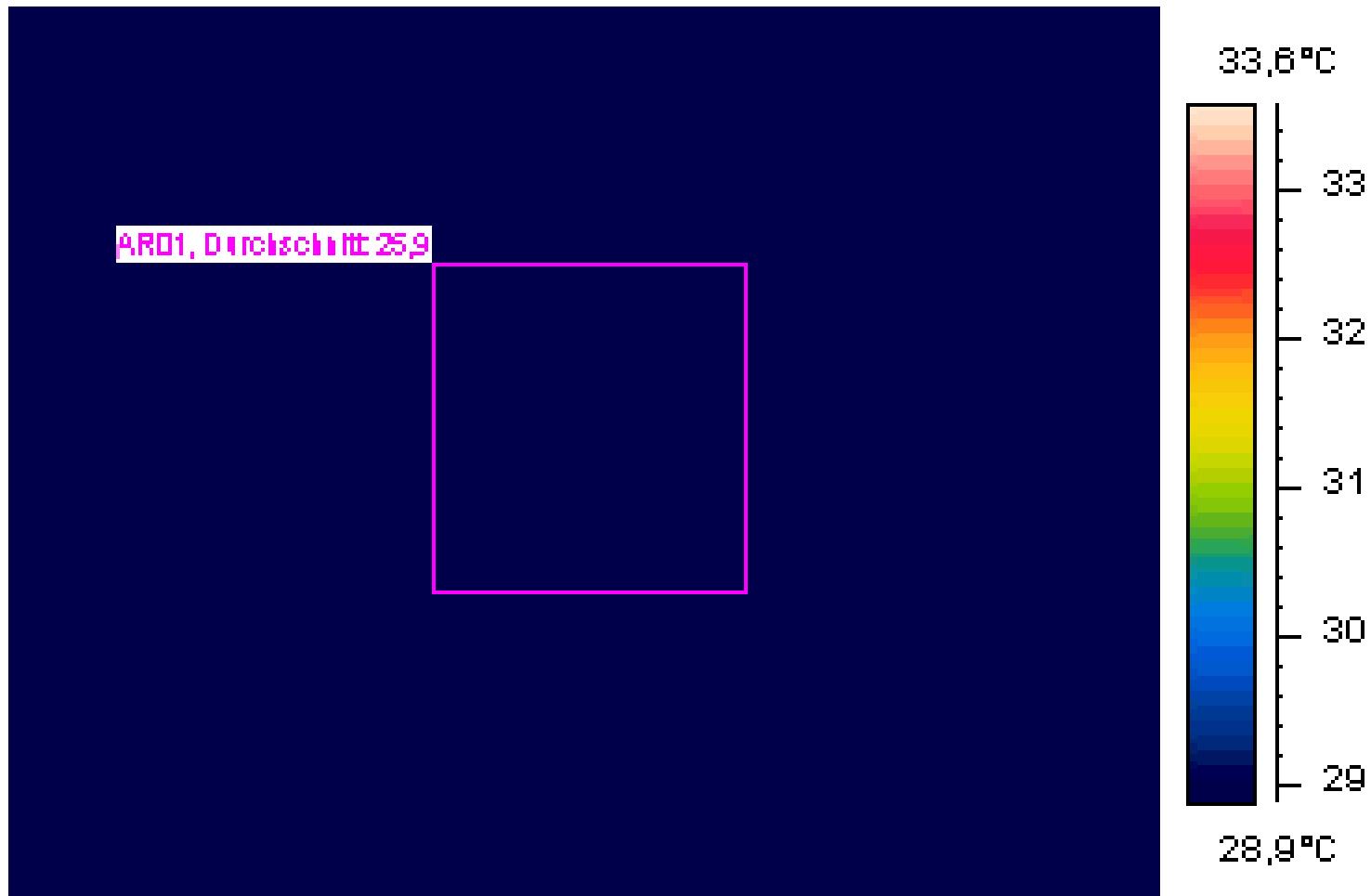
Power

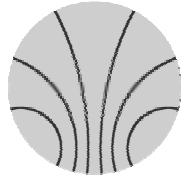




First ASIC Tests

Temperature



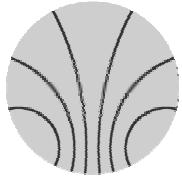


First ASIC Tests

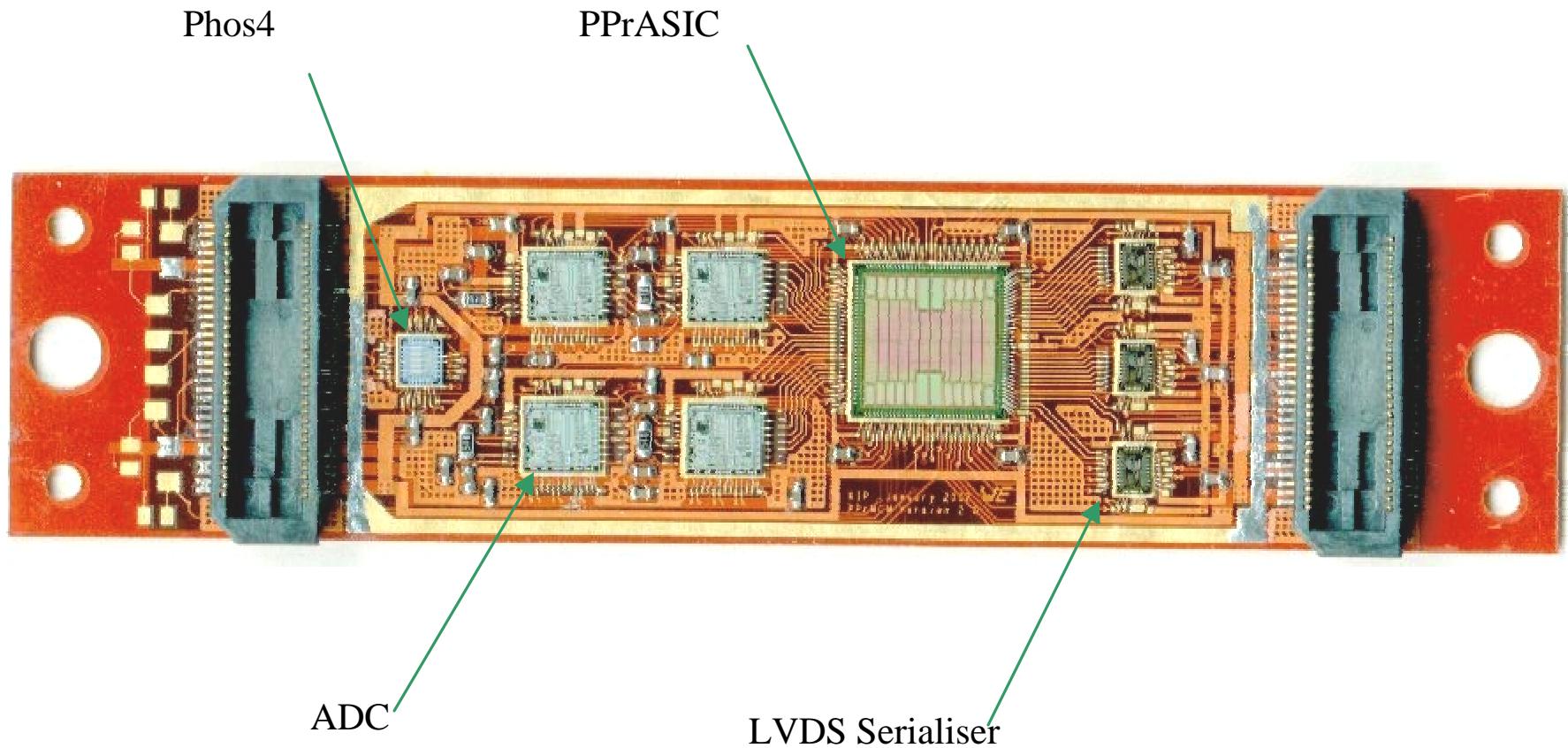
Temperature



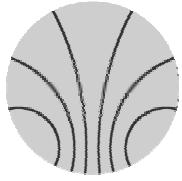
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



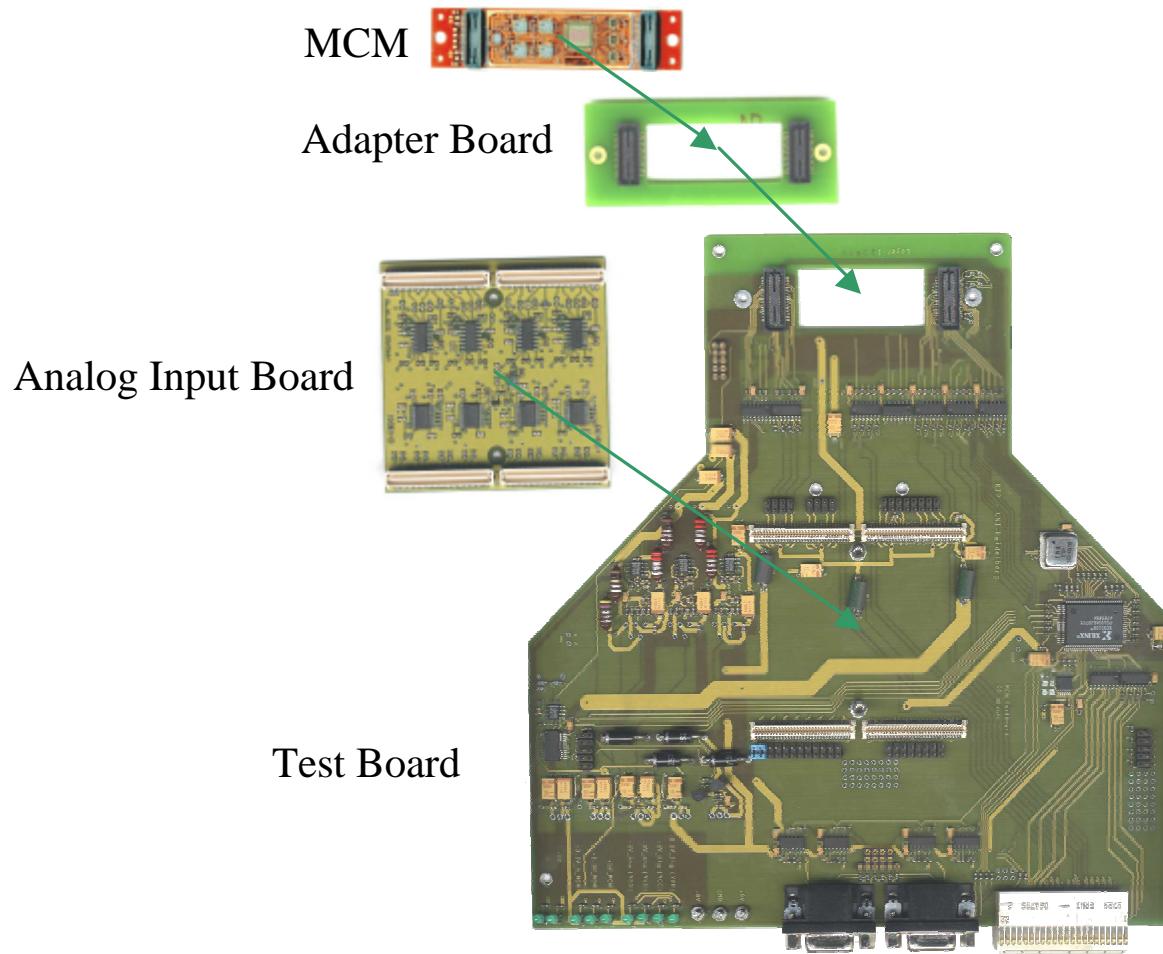
Mounted MCM



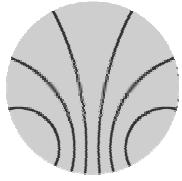
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



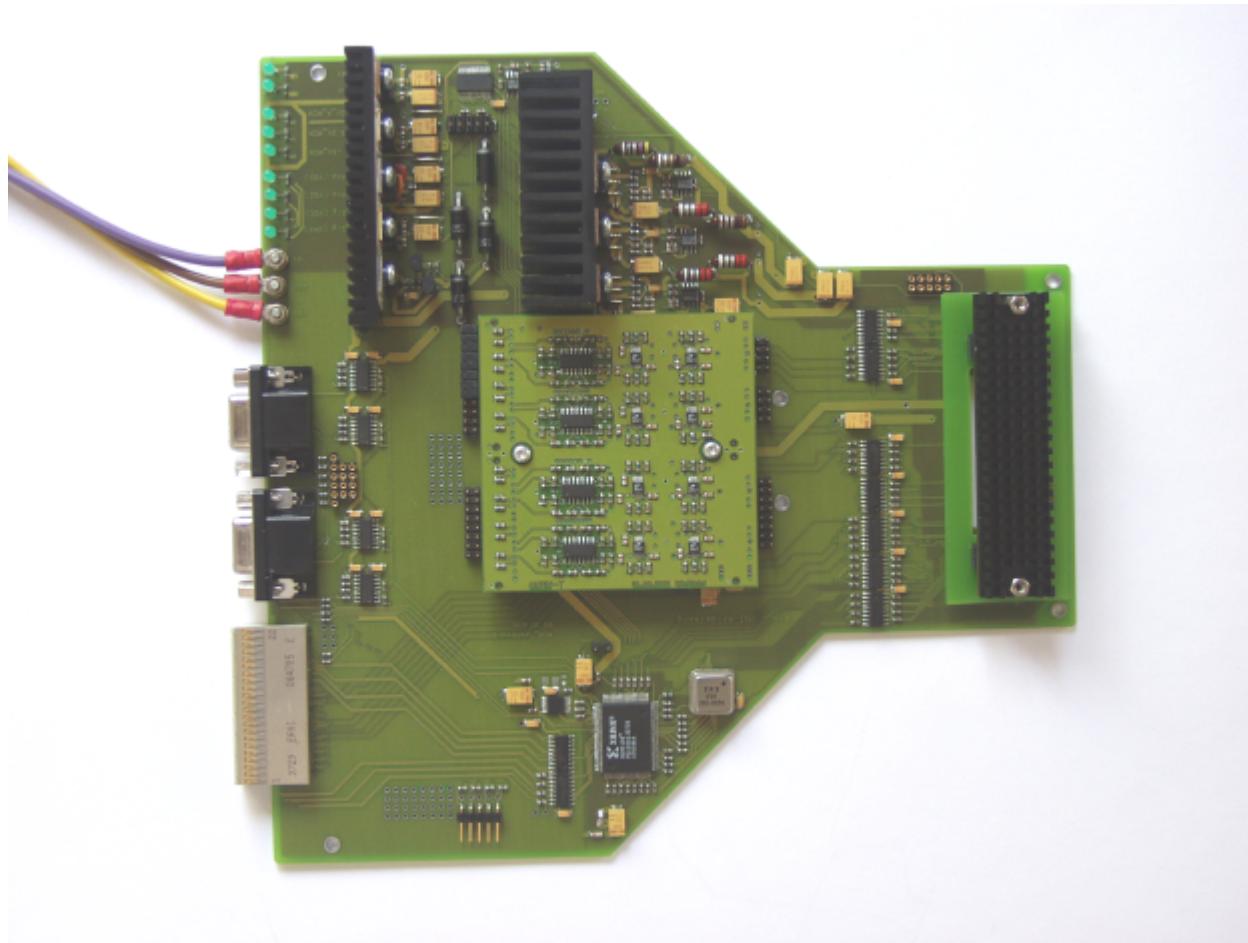
MCM-Test Parts



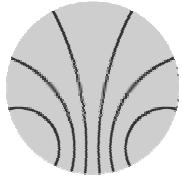
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



Mounted MCM-Test Board



Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



MCM Status and Test Plans



Temperature: <60°C@ Cooler, passive

Power consumption:

310mA @ 3.3V_{digital}

450mA @ 5V_{analog} for ADCs

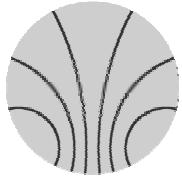
7mA @ 3.3V_{analog} for LVDS

Overall ~3.3W

First signs of life of the MCM, see KPs talk

Next Steps:

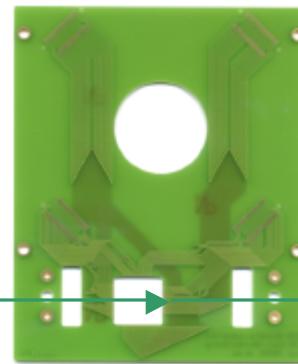
- Mounting of a 2nd MCM, with the fast LVDS serialiser.
- Completing the minimum setup of the test system Software/Firmware
- Learn to understand MCM-output
- ...



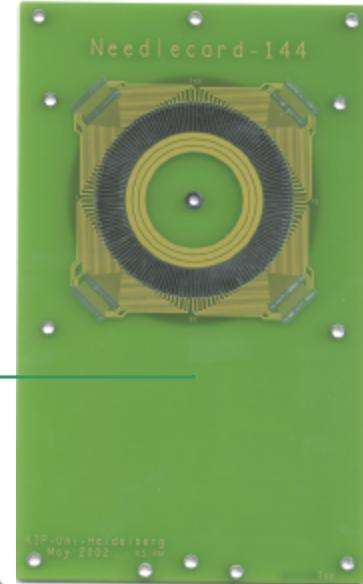
ASIC-Test Parts



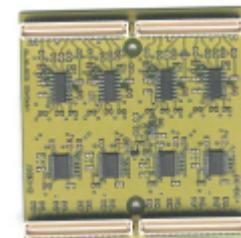
Needle Adapter Board



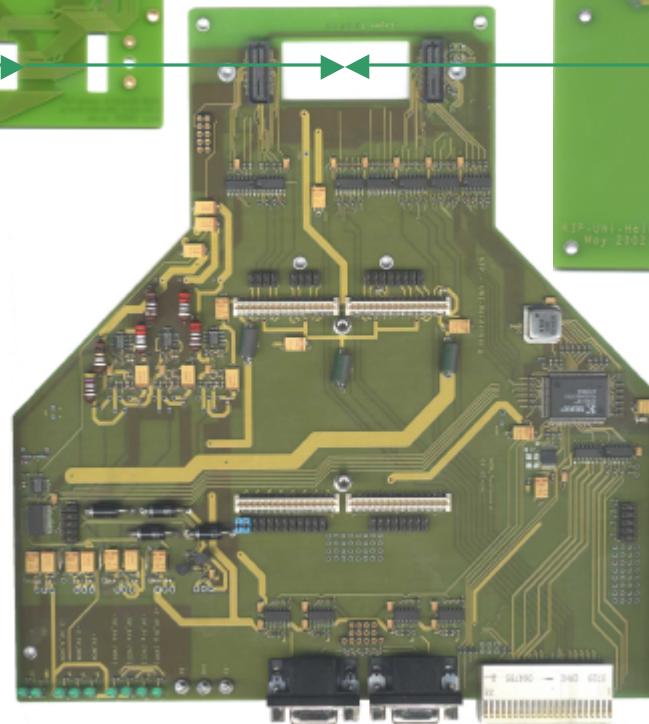
Needle Card



MCM
(minus PPrASIC)

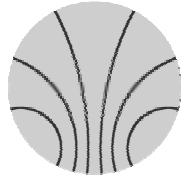


Analog Input Board

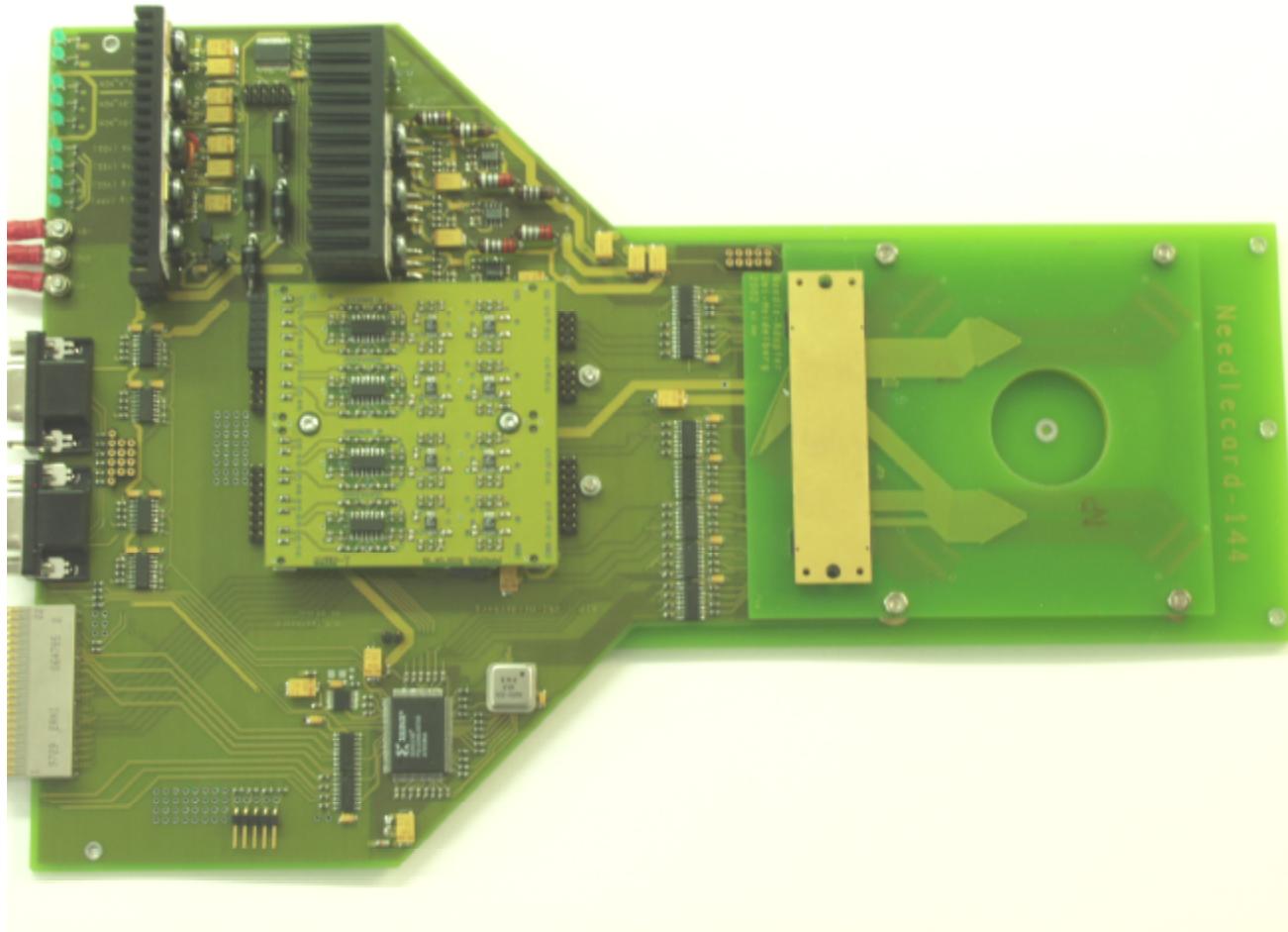


Test Board

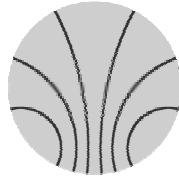
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



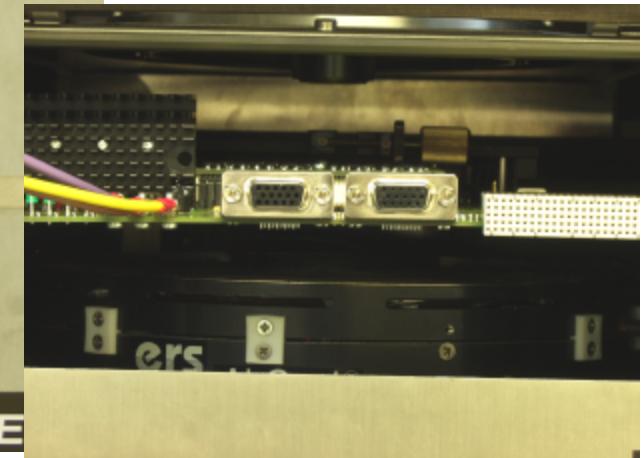
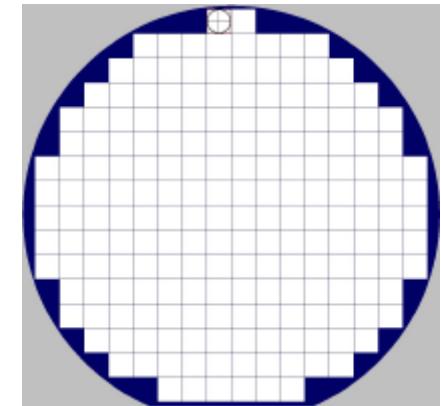
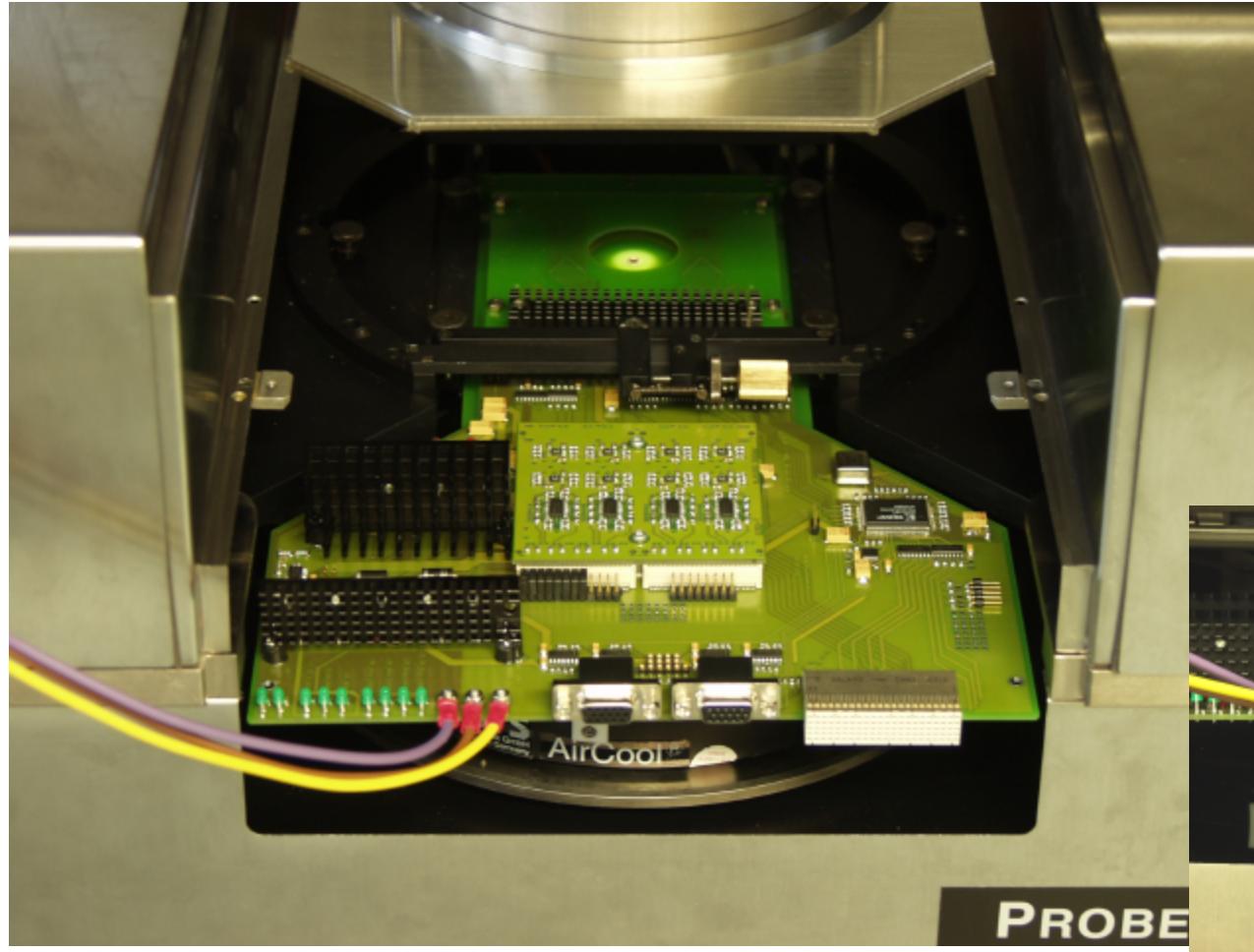
Mounted ASIC-Test Board



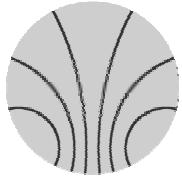
Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach



ASIC-Test Installed



Uni-Heidelberg/KIP/ASIC-Labor Ralf Achenbach

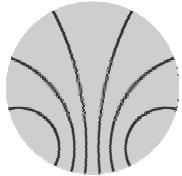


ASIC Test Plans



Next Steps:

- Mounting of an MCM without PPrASIC, but with the Needle Adapter Card.
- First “Die Probing” with ASIC-test System.
- Implementation of automatic MCM test in Waferprober system.



Outlook



Automatic test of MCM & ASIC must include

- Power test
- Data path output verification
- Configuration of ASIC
- Control path output verification

Additional MCM tests features

- Tolerance margins for output
- Phos4 test
- Bad component identification

The green light